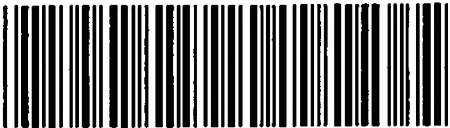


<b>Search Notes</b> 	<b>Application No.</b>	<b>Applicant(s)</b>	
	10/085,903	WEI ET AL.	
	<b>Examiner</b>	<b>Art Unit</b>	
	Hsien-Ming Lee	2823	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST attached (USPAT, USPG, EPO, JPO, IBM, derwent)	2/23/2004	LEE
IEEE search attached	2/23/2004	LEE